



US00D651411S

(12) **United States Design Patent**
Wahlquist et al.

(10) **Patent No.:** **US D651,411 S**
(45) **Date of Patent:** **** Jan. 3, 2012**

(54) **WIPE WITH PATTERN**

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(**) Term: **14 Years**

(21) Appl. No.: **29/367,489**

(22) Filed: **Aug. 9, 2010**

(51) **LOC (9) Cl.** **05-06**

(52) **U.S. Cl.** **D5/57; D5/53**

(58) **Field of Classification Search** D5/1, 3,
D5/4, 7, 47, 53, 54, 57-63, 99; D6/582,
D6/583, 592, 594; D19/5; D24/124, 126;
4/581; 5/490; 15/208, 209.1; 112/401, 402;
139/383 B, 383 R, 384 R; 162/109, 134;
428/32, 39, 187, 542.2, 542.6

See application file for complete search history.

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(57) **CLAIM**

The ornamental design for a wipe with pattern, as shown and
described.

DESCRIPTION

The sole FIGURE is a top plan view of a wipe with pattern
showing our new design. The broken lines in the drawing
define the boundaries of the wipe to which the pattern is
applied, and form no part of the claimed design. It is under-
stood that the pattern repeats uniformly throughout the length
and width of the design.

1 Claim, 1 Drawing Sheet



